

U.S. Department of Commerce, Patent and Trademark Office				Docket No. 8033064		Serial No. 10/000,001	
(PTO Form 1449 modified)							
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT				Applicant Wang et al.			
(Use several sheets if necessary)				Filing Date October 24, 2001		Group 2877	
Examiner		Unknown		COPY OF PAPERS ORIGINALLY FILED JUN 07 2001			
U.S. Patent Documents							
*Examiner Initial	Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date if Appropriate	
PJL	1	5,999,261	Pressesky et al.	255	954	7/10/98	
	2						
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	13						
Foreign Patent Documents							
*Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						YES	NO
	14					<input type="checkbox"/>	<input type="checkbox"/>
	15					<input type="checkbox"/>	<input type="checkbox"/>
	16					<input type="checkbox"/>	<input type="checkbox"/>
OTHER ART							
*Examiner Initial	Including Author, Title, Date, Pertinent Pages, Etc.						
PJL	17	Chris L. Koliopoulos, "Simultaneous phase shift interferometer", Advanced Optical Manufacturing and Testing II, Proc. SPIE Vol. 1531, p. 119-127 (1991).					
PJL	18	Jianmin Wang and Ian Grant, "ESPI, Phase mapping, NDT the techniques applied to real-time, thermal loading", Appl. Opt. 34, 3620-3627					
	19						
Examiner	PATRICK CONNELLY			Date Considered 9/20/03			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.							